

JITTER-LESS PHASE DETECTOR IN A CLOCK RECOVERY CIRCUIT

Field of the Invention

5 The present invention relates to a phase detector and, more particularly, to a jitter-less phase detector in a clock recovery circuit.

Background of the Invention

10 With the development of electronic technology, the dimension of electronic device is getting smaller and more compact. To save space and increase transmission speed, the serial transmission technology is in wide spread use. For example, the loader of the DVD-ROM or CD-ROM transfers signals serially. In such a serial transmission, a clock is recovered from the received data. Only when the correct clock is ensured, the
15 receiver can sample the received data correctly.

Referring to FIG. 1A, a conventional clock recovery circuit is illustrated. When the phase of a clock signal is lagged to the phase of DATA signal, the phase detector 91 outputs a frequency increasing signal (UP signal) for activating a current source 92 and charging a capacitor 93.
20 The voltage V_{COin} of the capacitor 93 will be increased due to charging of the capacitor 93. When the voltage V_{COin} is increased, the frequency of the output signals of a voltage-controlled oscillator 94 will be increased for compensating the lag phase of the clock CK. When the phase of the clock signal CK is leading the phase of the data signal DATA, the phase detector
25 91 outputs a frequency decreasing signal (DN signal) for driving a current source 95 and the capacitor 93 will be discharged. The voltage V_{COin} of the capacitor 93 will be decreased due to the discharge. After the voltage

VCOin is decreased, the frequency of the output signal of the voltage-controlled oscillator 94 is also decreased so that the phase of the clock signal CK is lagged to be in-phase with the data signal DATA.

FIGS. 1B and 1C show the circuit and time sequence of the phase detector 91 of the clock recovery circuit. In FIG. 1C, arrow A represents that the clock signal CK and data signal DATA are in phase, arrow B represents that phase of the signal CK is lagged of the data signal DATA, and arrow C represents that phase of the signal CK is led of the data signal DATA. When the clock signal CK is in-phase with the data signal DATA, the voltage VCOin still exists, as indicated by arrow D in FIG. 1C. This will cause jitter in the clock signal and meanwhile, the voltage VCOin generates a DC offset so that the phase of the clock CK has offset with respect to the phase of the data signal DATA.

FIGS. 2A and 2B show the improved circuit and time sequence of the clock recovery circuit for solving the aforementioned problem. As shown in the FIG. 2B, the phase detector 91 can eliminate the DC offset of the voltage VCOin, while as indicating by arrow D of FIG. 2B, it is found that the clock still has jitters.

Therefore, it is desirable to provide an improved phase detector with jitter-less for a clock recovery circuit to mitigate and/or obviate the aforementioned problems.

Summary of the invention

Accordingly, the primary object of the present invention is to provide a jitter-less phase detector in a clock recovery circuit, wherein the jitter of a clock recovery circuit can be reduced effectively.

To achieve the above object, the present jitter-less phase detector in a clock recovery circuit comprises: a first control signal generating circuit for generating a first control signal by inverting and delaying input data signals through half clock ($0.5T$), so that the first control signal has a pulse width starting from a transition of the data signal and lasting for half clock;
5 a second control signal generating circuit for generating a high level second control signal when the data signal changes, so that the second control signal has a pulse width starting from a transition of the data signal and terminating at a falling edge of the clock; and a phase comparator for
10 generating an up signal having a high-level from the falling edge of the first control signal to the falling edge of the second control signal when the falling edge of the first control signal is leading the falling edge of the second control signal, and generating a down signal having a high-level from the falling edge of the second control signal to the falling edge of the
15 first control signal when the falling edge of the second control signal is leading the falling edge of the first control signal, so as to control a pair of current sources to selectively discharge and charge a capacitor.

The various objects and advantages of the present invention will be more readily understood from the following detailed description when read
20 in conjunction with the appended drawing.

Brief Description of the Drawings

FIG. 1A shows a block diagram of a conventional clock recovery circuit;
FIG. 1B shows a circuit diagram of a phase detector of the FIG. 1A;
25 FIG. 1C shows a timing sequence of the FIG. 1B circuit;
FIG. 2A shows another circuit diagram of the phase detector circuit;
FIG. 2B shows a timing sequence of the FIG. 2A circuit;

FIG. 3A shows a block diagram of the phase detector with jitter-less in a clock recovery circuit of the present invention;

FIG. 3B shows a timing sequence of a phase detector with jitter-less in a clock recovery circuit of the present invention;

5 FIG. 4A shows an exemplary circuit diagram of the phase detector with jitter-less in a clock recovery circuit of the present invention; and

FIG. 4B shows an exemplary circuit of the inverted delay circuit of Fig. 4A.

Detailed Description of the Preferred Embodiments

FIG. 3A shows the jitter-less phase detector in a clock recovery circuit
10 of the present invention, which includes a first control signal generating circuit 10, a second control signal generating circuit 20, and a phase comparator 30. The first control signal generating circuit 10 generates a high-level first control signal X when the input data signal DATA is transited (from high-level to lower-level, or from lower-level to high-level).
15 The pulse width of the first control signal X is defined to start from the transition of the data signal and last for half period ($0.5T$), as shown in FIG. 3B. The second control signal generating circuit 20 generates a high-level second control signal Y when the input data signal DATA is transited (from high-level to lower-level, or from lower-level to high-level). The pulse
20 width of the second control signal Y is defined to start from the transition of the data signal and terminate at a falling edge of the clock, as shown in FIG. 3B. The phase comparator 30 generates an up signal, denoted as UP, and a down signal, denoted as DN, according to the first control signal X and the second control signal Y. When the falling edge of the first control
25 signal X is leading the falling edge of the second control signal Y, the phase comparator 30 generates the UP signal. The high-level pulse width of the UP signal is from the falling edge of the first control signal X to the falling

edge of the second control signal Y, as indicated by arrow F of FIG. 3B. When the falling edge of the second control signal Y is leading the falling edge of the first control signal X, it generates a DN signal. The high-level pulse width of the DN signal is from the falling edge of the second control signal Y to the falling edge of the first control signal X, as indicated by arrow G of FIG. 3B.

FIG. 4A shows the circuit diagram of the jitter-less phase detector in a clock recovery circuit of the present invention. The first control signal generating circuit 10 comprises an inverting delay circuit 11 and an XNOR gate 12 for delaying the input signal with $0.5 T$. The data signal DATA is applied to an input end of the inverting delay circuit 11 to generate an inverting delayed data signal $DATA_{0.5T^*}$. The data signal DATA and the inverting delay data signal $DATA_{0.5T^*}$ are applied to the input ends of the XOR gate 12. After being operated by the XOR gate 12, the first control signal X is generated.

The second control signal generating circuit 20 is formed by a D-type flip-flop 21 and an XOR gate 22. The clock end CP of the D-type flip-flop 21 is connected to an inverse clock signal CK^* . The data signal DATA is applied to the data input end D of the D-type flip-flop 21. A $DATA_D$ signal is outputted from the D-type flip-flop 21. The $DATA_D$ signal and the data signal DATA are applied to the input ends of the XOR gate 22. After operation of the XOR gate 22, the second control signal Y is generated.

The phase comparator 30 comprises a D-type flip-flop 31, a D-type flip-flop 32, and an AND gate 33. The first control signal X and the second control signal Y are applied to the inverted clock input ends of the flip-flop 31 and flip-flop 32, respectively. The data input ends D of the D-type

flip-flop 31 and D-type flip-flop 32 are connected to high-level voltage (1). The outputs Q of the D-type flip-flop 31 and D-type flip-flop 32 are labeled as UP signal and DN signal. The UP signal and DN signal are applied to the input ends of the AND gate 33. The output of the AND gate 33 is connected
5 to the reset ends (CLR) of the D-type flip-flop 31 and D-type flip-flop 32, respectively.

When the levels of the first control signal X and second control signal Y change from low-level to high-level simultaneously, and then change from high-level to low-level simultaneously again, the UP and DN
10 signals are at high-level in advance simultaneously. The voltage V_a outputted from the AND gate 33 is at high-level and it will asynchronously reset the D-type flip-flop 31 and D-type flip-flop 32, such that UP and DN signals change to low-level simultaneously. Then, voltage V_a changes to low-level. Since DN and UP signals change to low-level simultaneously,
15 the voltage of V_{COin} is equal to 0, as indicated by arrow H of FIG. 3B. When the first control signal X and second control signal Y change from low-level to high-level simultaneously, and the first control signal X changes from high-level to lower-level before the transition of the second control signal Y, the transition of the first control signal X from high-level
20 to low-level will cause the UP signal to change to high-level. When the second control signal Y changes from high-level to low-level, the UP signal will change to low-level, as indicated by arrow F of FIG. 3B. Under the condition that the first control signal X and second control signal Y change from low-level to high-level, and the second control signal Y changes from
25 high-level to low-level before the transition of the first control signal X, when the second control signal Y changes from high-level to low-level, the DN signal will change to high-level. When the first control signal X

changes from high-level to low-level, the DN signal will change to low-level, as indicated by arrow G of FIG. 3B. Under the condition that the first control signal X and second control signal Y change from low-level to high-level and the first control signal X and the second control signal Y change from low-level to high-level, the clock signal CK and the data signal DATA are in phase and the voltage VCOin is equal to 0, as indicated by arrow H in FIG. 3B. Therefore, the jitter of clock is reduced and meanwhile the DC offset generated by the voltage VCOin is cancelled.

FIG. 4B shows a detail circuit of the inverted delay circuit 11 in FIG. 4A. The data signal DATA passes through three CMOS gates for generating an inverted signal DATA_0.5T* with a 0.5T delay. When the clock signal passes through three CMOS gates, the signal level changes from high-level to low-level or from low-level to high-level. That is, the path delay of the three CMOS gates is also half clock of the clock signal (0.5T). Therefore, when the data signal DATA passes through three CMOS gates, a delay of 0.5T and an inverted second signal DATA_0.5T* are generated.

Although the present invention has been explained in relation to its preferred embodiment, it is to be understood that many other possible modifications and variations can be made without departing from the spirit and scope of the invention as hereinafter claimed.